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Quarterly Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2023 Based on structural similarity

Supplier		User Part Number				
Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test		BZX84W-C3V0-Q Part Description				
		SMD package				
		Test Conditions	Duration	# Lots	# Quantity	# Rejects
			TEST			
# E1	Pre- and Post-Stress Electrical Test	T			- 11	
# E1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below
		JESD22-A113 Bake Tamb = 125 °C	24 hours			
	PC	Soak Tamb = $85 ^{\circ}$ C, RH = 85%	168 hours			
# A1	Preconditioning	Reflow soldering	3 cycles	1514	64430	0
# A1	Treconditioning	5	5 Cycles	1314	04450	0
	HTRB	MIL-STD-750-1 M1038 Method A				
		$T_j = T_j max$, VR = 80 % of rated reverse				
# B1	Bias	voltage	1000 hours	250	11400	0
# D1	Bid3	MIL-STD-750-1	1000 110013	230	11400	0
		MIL-STD-750-1 M1038 Method B				
	SSOP	$T_j = T_j max$, $I_z = 100\%$ of max. datasheet				
# B1b	Steady State Operational	reverse current	1000 hours	44	1920	0
# 010	occur, ocure operational		1000 110013		1520	0
	тс	JESD22-A104				
# A4	Temperature Cycling	-65 °C to Tjmax, not to exceed 150°C	1000 cycles	311	14080	0
π Ατ	remperature eyemig		1000 cycles	511	14000	0
	UHAST	JESD22-A118				
# A3 or	Unbiased HAST	Tamb = $130 ^{\circ}$ C, RH = $85 ^{\circ}$	96 hours	311	14080	0
		JESD22-A102				
	AC	Tamb = $121 ^{\circ}C$, RH = $100 ^{\circ}M$				
# A3 alt	Autoclave	Pressure = $205 \text{ kPa} (29.7 \text{ psia})$				
	, acodave					
	H3TRB	JESD22-A101				
	High Humidity High	Tamb = 85 °C, RH = 85%, VR = 80 % of				
# A2 alt	Temperature Reverse Bias		1000 hours	311	14080	0
		MIL-STD-750 Method 1037			1.000	-
	IOL	ton = toff, devices powered to insure ΔT_j =				
# A5	Intermittent Operating Life	, , , ,	1000 hours	312	14120	0
						-
	RSH	JESD22-A111				
# C8	Resistance to Solder Heat	260 °C ± 5 °C	10 s	269	8070	0
	SD		_,,,	_00	2070	-
# C10	Solderability	J-STD-002		19	6660	0
. 010						<u> </u>

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

2,68E+09

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